## Notice of References Cited Application/Control No. 10/771,770 Examiner Nam V. Nguyen Applicant(s)/Patent Under Reexamination ELAM ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	ÚS-5,347,164	09-1994	Yeh, Wen-Jen	307/66
	В	⊍S-			
	С	US-			
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	E	US-			·
	H-	US-			
	G	US-			
	Н	US-			
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	J	US-			
	K	US-			
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## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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